

**Search Notes**

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Examiner

Le Nguyen

Applicant(s)/Patent under  
Reexamination

NADADUR ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner
715	792	1/6/2007	LVN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PG Pub, USPAT: 715/792		1/6/2007	LVN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor name search	1/6/2007	LVN
US-PG Pub, USPAT: 715/782-783, 790-797,804,808-809; 382/128,131,305; 705/2-3; 707/104.1,3.	1/6/2007	LVN